

# PHX18NQ11T

N-channel TrenchMOS™ standard level FET

Rev. 01 — 13 February 2004

Product data

## 1. Product profile

### 1.1 Description

N-channel enhancement mode field-effect power transistor in a fully isolated plastic package using TrenchMOS™ technology.

### 1.2 Features

- Low on-state resistance
- Isolated mounting base
- Fast switching
- Low thermal resistance

### 1.3 Applications

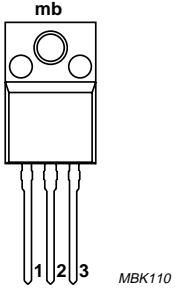
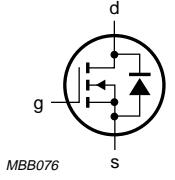
- DC-to-DC converters
- Switched-mode power supplies

### 1.4 Quick reference data

- $V_{DS} \leq 110$  V
- $I_D \leq 12.5$  A
- $P_{tot} \leq 31.2$  W
- $R_{DSon} \leq 90$  mΩ

## 2. Pinning information

Table 1: Pinning - SOT186A (TO-220F), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)		
2	source (s)		
3	drain (d)		
mb	mounting base; isolated	 MBK110	 MBB076

SOT186A (TO-220F)



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### 3. Ordering information

**Table 2: Ordering information**

Type number	Package			Version
	Name	Description		
PHX18NQ11T	TO-220F	Plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3 lead TO-220AB 'full pack'		SOT186A

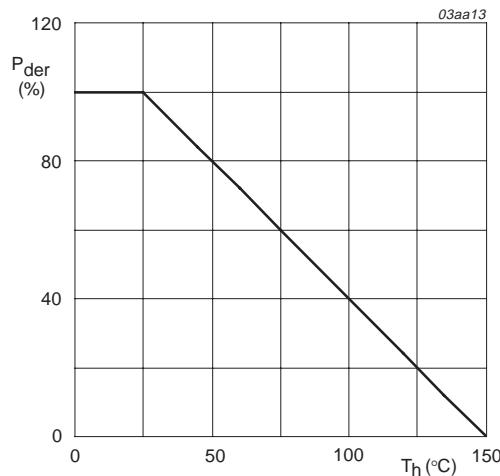
### 4. Limiting values

**Table 3: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

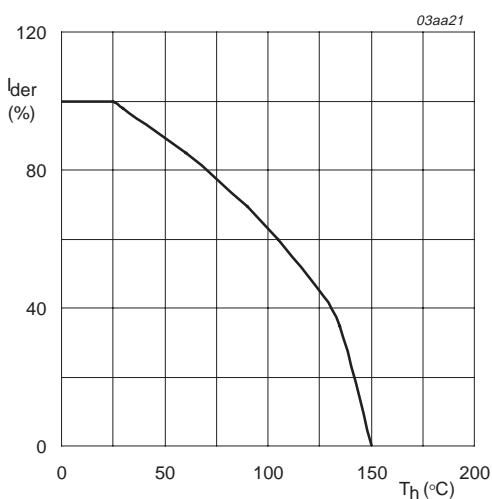
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage (DC)	$25^{\circ}\text{C} \leq T_j \leq 150^{\circ}\text{C}$	-	110	V
$V_{DGR}$	drain-gate voltage (DC)	$25^{\circ}\text{C} \leq T_j \leq 150^{\circ}\text{C}; R_{GS} = 20\text{ k}\Omega$	-	110	V
$V_{GS}$	gate-source voltage (DC)		-	$\pm 20$	V
$I_D$	drain current (DC)	$T_h = 25^{\circ}\text{C}; V_{GS} = 10\text{ V}$ ; Figure 2 and 3	[1]	-	A
		$T_h = 100^{\circ}\text{C}; V_{GS} = 10\text{ V}$ Figure 2	[1]	-	A
$I_{DM}$	peak drain current	$T_h = 25^{\circ}\text{C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; Figure 3	[1]	-	A
$P_{tot}$	total power dissipation	$T_h = 25^{\circ}\text{C}$ ; Figure 1	[1]	-	W
$T_{stg}$	storage temperature		-55	+150	$^{\circ}\text{C}$
$T_j$	junction temperature		-55	+150	$^{\circ}\text{C}$
<b>Source-drain diode</b>					
$I_S$	source (diode forward) current (DC)	$T_h = 25^{\circ}\text{C}$	[1]	-	A
$I_{SM}$	peak source (diode forward) current	$T_h = 25^{\circ}\text{C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	[1]	-	A
<b>Avalanche ruggedness</b>					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 7.5\text{ A}$ ; $t_p = 0.09\text{ ms}$ ; $V_{DD} \leq 15\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; starting $T_j = 25^{\circ}\text{C}$	-	56	mJ

[1] External heatsink connected to mounting base.



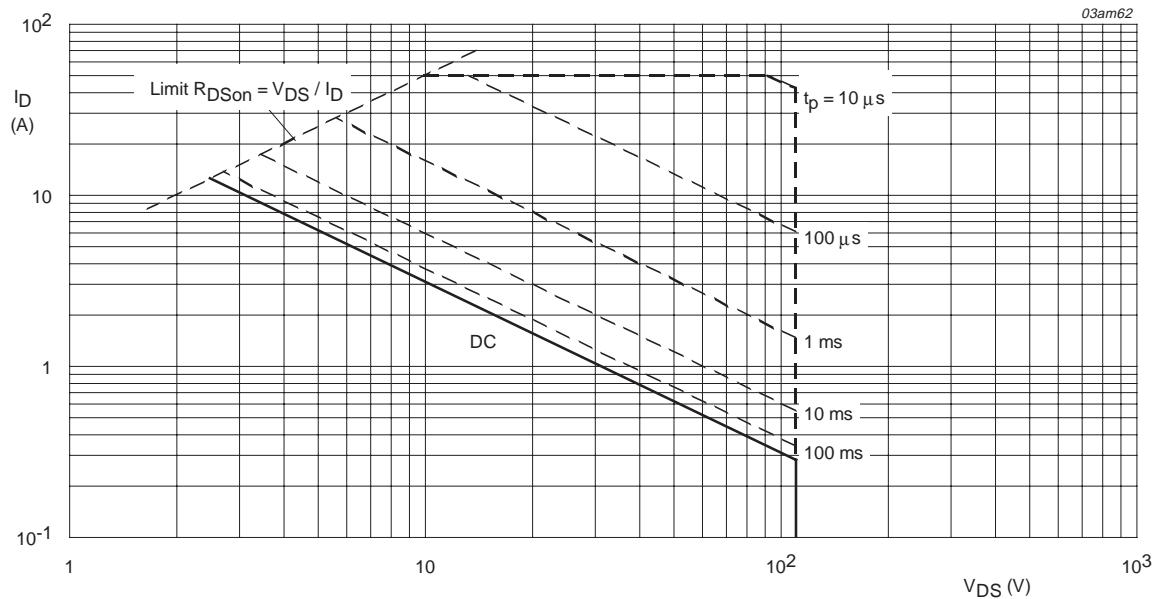
$$P_{der} = \frac{P_{tot}}{P_{tot}(25^\circ C)} \times 100\%$$

**Fig 1.** Normalized total power dissipation as a function of heatsink temperature.



$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

**Fig 2.** Normalized continuous drain current as a function of heatsink temperature.



$T_h = 25^\circ C$ ;  $I_{DM}$  is single pulse;  $V_{GS} = 10\ V$

**Fig 3.** Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

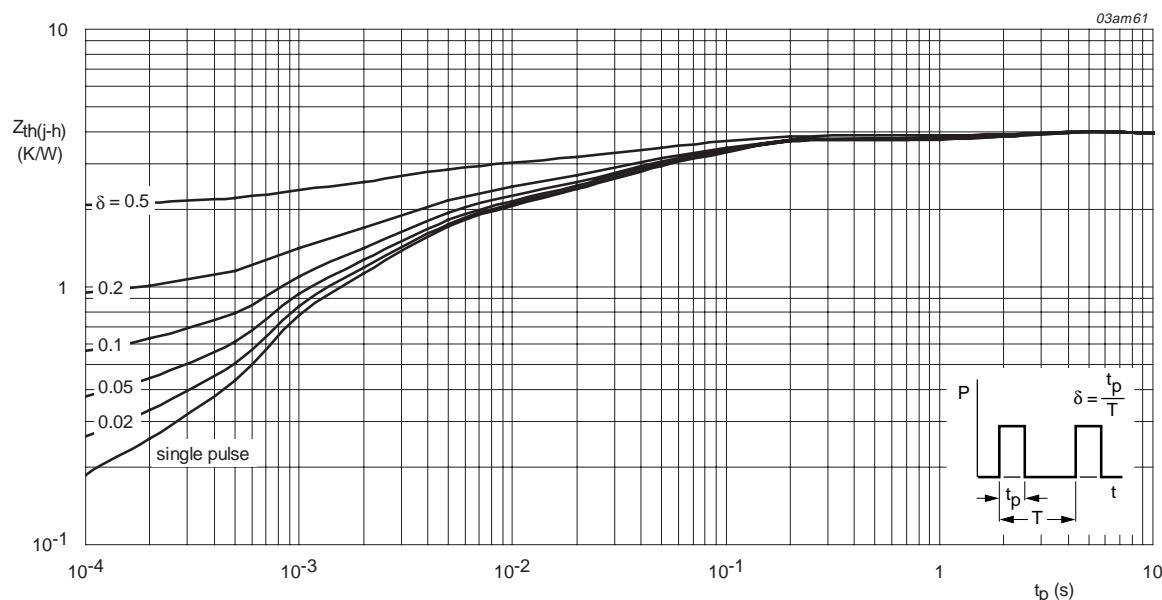
## 5. Thermal characteristics

**Table 4: Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-h)}$	thermal resistance from junction to heatsink	Figure 4	[1]	-	-	K/W

[1] External heatsink connected to mounting base.

### 5.1 Transient thermal impedance



**Fig 4. Transient thermal impedance from junction to heatsink as a function of pulse duration.**

## 6. Characteristics

**Table 5: Characteristics** $T_j = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(\text{BR})\text{DSS}}$	drain-source breakdown voltage	$I_D = 250 \mu\text{A}; V_{GS} = 0 \text{ V}$				
		$T_j = 25^\circ\text{C}$	110	-	-	V
		$T_j = -55^\circ\text{C}$	99	-	-	V
$V_{GS(\text{th})}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$ ; Figure 9				
		$T_j = 25^\circ\text{C}$	2	3	4	V
		$T_j = 150^\circ\text{C}$	1.2	-	-	V
		$T_j = -55^\circ\text{C}$	-	-	4.4	V
$I_{DSS}$	drain-source leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}$				
		$T_j = 25^\circ\text{C}$	-	-	1	$\mu\text{A}$
		$T_j = 150^\circ\text{C}$	-	-	500	$\mu\text{A}$
$I_{GSS}$	gate-source leakage current	$V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nA
$R_{DS\text{on}}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 9 \text{ A}$ ; Figure 7 and 8				
		$T_j = 25^\circ\text{C}$	-	67	90	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	-	148	198	$\text{m}\Omega$
<b>Dynamic characteristics</b>						
$Q_{g(\text{tot})}$	total gate charge	$I_D = 3 \text{ A}; V_{DD} = 80 \text{ V}; V_{GS} = 10 \text{ V}$ ; Figure 13	-	21	-	nC
$Q_{gs}$	gate-source charge		-	2.5	-	nC
$Q_{gd}$	gate-drain (Miller) charge		-	8	-	nC
$C_{iss}$	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ ; Figure 11	-	635	-	pF
$C_{oss}$	output capacitance		-	105	-	pF
$C_{rss}$	reverse transfer capacitance		-	60	-	pF
$t_{d(\text{on})}$	turn-on delay time	$V_{DD} = 50 \text{ V}; R_L = 15 \Omega; V_{GS} = 10 \text{ V}; R_G = 5.6 \Omega$	-	6	-	ns
$t_r$	rise time		-	12	-	ns
$t_{d(\text{off})}$	turn-off delay time		-	20	-	ns
$t_f$	fall time		-	10	-	ns
<b>Source-drain diode</b>						
$V_{SD}$	source-drain (diode forward) voltage	$I_S = 12 \text{ A}; V_{GS} = 0 \text{ V}$ ; Figure 12	-	0.87	1.2	V
$t_{rr}$	reverse recovery time	$I_S = 12 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$	-	55	-	ns
$Q_r$	recovered charge		-	135	-	nC

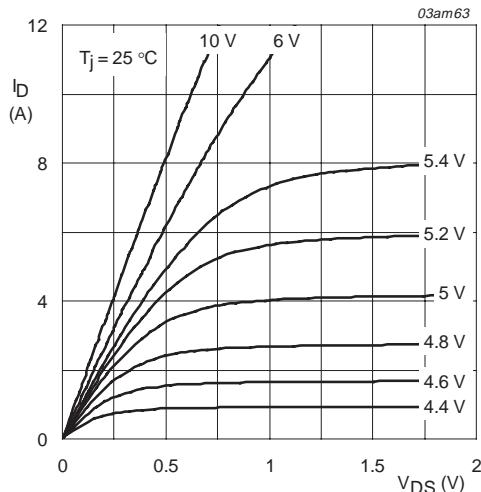


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.

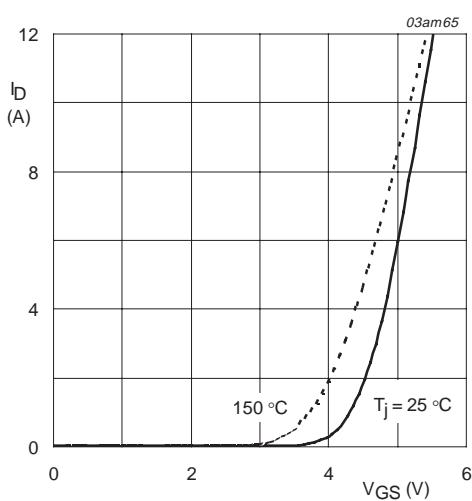


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.

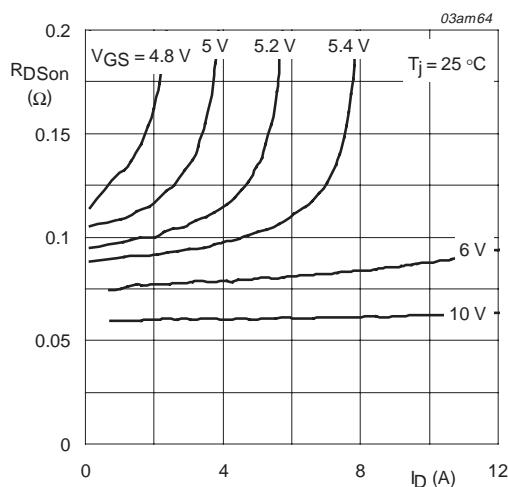


Fig 7. Drain-source on-state resistance as a function of drain current; typical values.

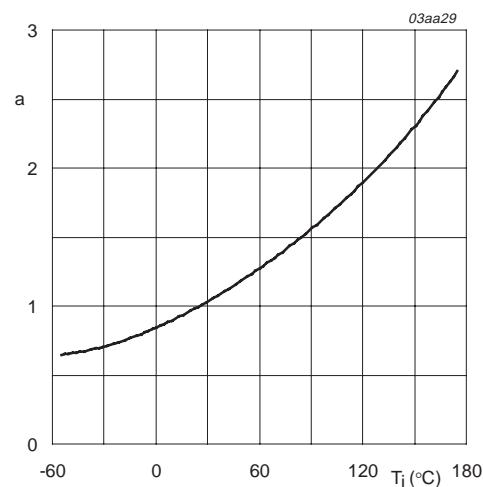
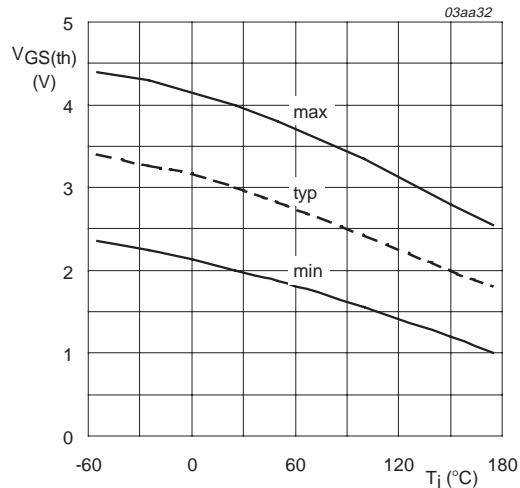
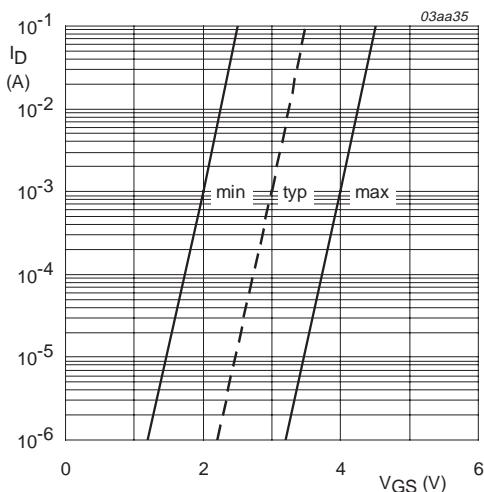


Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



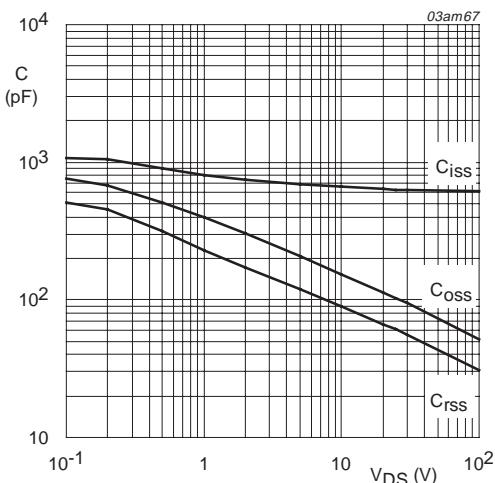
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

**Fig 9. Gate-source threshold voltage as a function of junction temperature.**



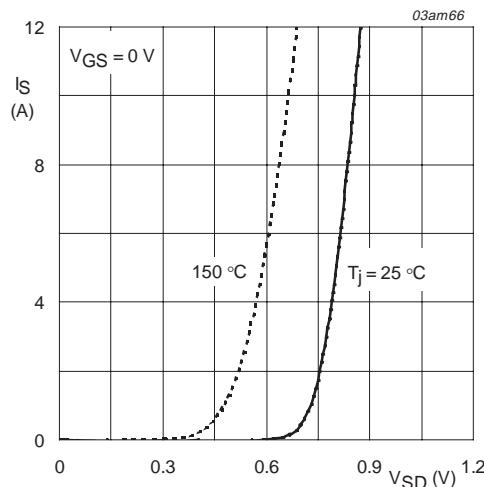
$T_j = 25^\circ\text{C}$

**Fig 10. Sub-threshold drain current as a function of gate-source voltage.**



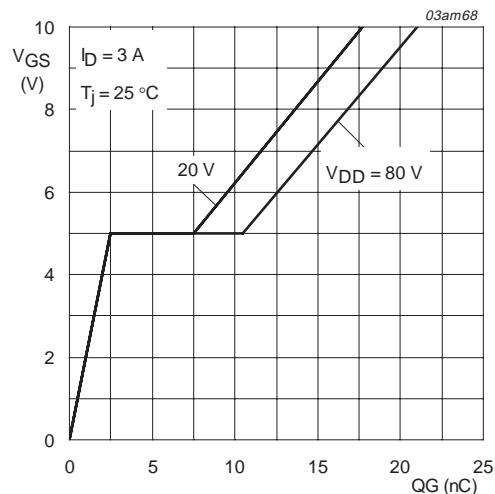
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**



$T_j = 25 \text{ }^\circ\text{C}$  and  $150 \text{ }^\circ\text{C}$ ;  $V_{GS} = 0 \text{ V}$

**Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$I_D = 3 \text{ A}$ ;  $V_{DD} = 20 \text{ V}$  and  $80 \text{ V}$

**Fig 13. Gate-source voltage as a function of gate charge; typical values.**

## 7. Isolation characteristics

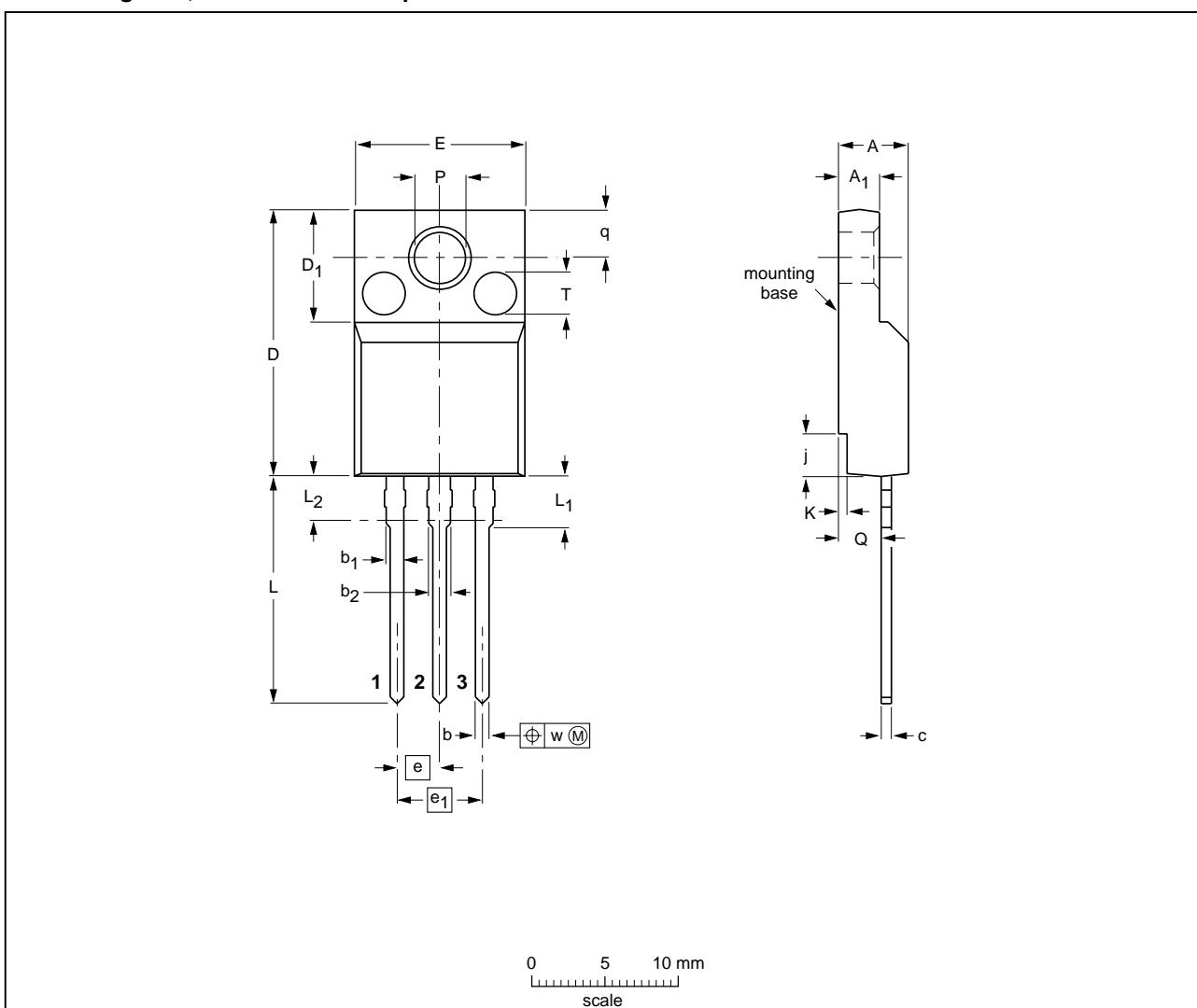
**Table 6: Isolation characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$V_{(isol)RMS}$	RMS isolation voltage from all three terminals to external heatsink	$f = 50\text{-}60 \text{ Hz}$ ; sinusoidal waveform; $\text{RH} \leq 65\%$ ; clean and dust-free.	-	-	2500	V
$C_{(d-h)}$	Capacitance from drain to external heatsink		-	10	-	pF

## 8. Package outline

Plastic single-ended package; isolated heatsink mounted;  
1 mounting hole; 3 lead TO-220 'full pack'

SOT186A



### DIMENSIONS (mm are the original dimensions)

UNIT	A	A <sub>1</sub>	b	b <sub>1</sub>	b <sub>2</sub>	c	D	D <sub>1</sub>	E	e	e <sub>1</sub>	j	K	L	L <sub>1</sub>	L <sub>2</sub> <sup>(1)</sup> max.	P	Q	q	T <sup>(2)</sup>	w
mm	4.6 4.0	2.9 2.5	0.9 0.7	1.1 0.9	1.4 1.0	0.7 0.4	15.8 15.2	6.5 6.3	10.3 9.7	2.54 2.08	5.08 1.7	2.7 1.7	0.6 0.4	14.4 13.5	3.30 2.79	3	3.2 3.0	2.6 2.3	3.0 2.6	2.5 2.5	0.4

### Notes

1. Terminal dimensions within this zone are uncontrolled. Terminals in this zone are not tinned.
2. Both recesses are Ø 2.5 × 0.8 max. depth

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT186A		3-lead TO-220F				-02-03-12 02-04-09

Fig 14. SOT186A (TO-220F).

## 9. Revision history

Table 7: Revision history

Rev	Date	CPCN	Description
01	20040213	-	Product data (9397 750 12915)

## 10. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2][3]</sup>	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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